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|-----------------------------------|--|--|-------------------------|--|-------------|
| Notice of References Cited | | | Application/Control No. | Applicant(s)/Patent Under Reexamination CHEN ET AL. | |
| | | | Examiner Eugene Lee | Art Unit 2815 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-6,521,948 B2 | 02-2003 | Ebina, Akihiko | 257/347 |
| | B | US-6,734,500 B2 | 05-2004 | Ebina, Akihiko | 257/347 |
| | C | US-5,821,575 A | 10-1998 | Mistry et al. | 257/281 |
| | D | US-6,657,257 B2 | 12-2003 | Ohyanagi et al. | 257/347 |
| | E | US-5,973,364 A | 10-1999 | Kawanaka, Shigeru | 257/347 |
| | F | US-5,920,093 A | 07-1999 | Huang et al. | 257/347 |
| | G | US-6,693,326 B2 | 02-2004 | Adan, Alberto O. | 257/347 |
| | H | US-5,844,272 A | 12-1998 | Soderbarg et al. | 257/328 |
| | I | US-6,642,579 B2 | 11-2003 | Fung, Ka Hing | 257/347 |
| | J | US-6,404,015 B2 | 06-2002 | Emmerik et al. | 257/348 |
| | K | US-6,191,449 B1 | 02-2001 | Shino, Tomoaki | 257/347 |
| | L | US-6,353,245 B1 | 03-2002 | Unnikrishnan, Sreenath | 257/347 |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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